

<b>Search Notes</b> 				<b>Application/Control No.</b> 10/772,311 <b>Examiner</b> EDMUND H. LEE	<b>Applicant(s)/Patent under Reexamination</b> LEE ET AL. Art Unit 1732
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>	
Class	Subclass	Date	Examiner		DATE
				east	9/4/2007
				inventor	EHL
				264/272.14,272.15,272.17,161,328.9, 328.12	
<b>INTERFERENCE SEARCHED</b>					
Class	Subclass	Date	Examiner		